

**AMENDMENTS TO THE CLAIMS**

Please cancel claims 13 and 16-22, as set forth in the listing of claims that follows:

1. (Cancelled)

2. (Previously Presented) The component of claim 4, wherein the electrical component is a substrate having an electrical circuit formed on at least one surface of the substrate and at least one semi-conductor chip electrically connected to the electrical circuit.

3. (Cancelled)

4. (Previously Presented) An overmolded electrical component, comprising:
  - a circuit board substrate having an electrical circuit;
  - a semi-conductor chip overlying the substrate and spaced apart therefrom by a distance of about 10 micrometers to about 150 micrometers, thereby creating a space between the circuit board substrate and the semi-conductor chip;
  - solder interconnections located within the space and connecting the electrical circuit to the semiconductor chip; and
  - a polymeric overmolding encapsulating the semi-conductor chip on the substrate and filling the space between the semi-conductor chip and the substrate about the solder interconnections, said polymeric overmolding being composed of a polymeric composite including a synthetic resin matrix and inorganic filler particles substantially uniformly distributed in the synthetic resin matrix, the inorganic filler particles having a platelet structure defined by opposite substantially flat and substantially parallel faces and being characterized by a dimensions between about 1 and 700 nanometers, the inorganic filler particle content being 20 percent or less by weight based on the weight of the polymeric composite.

5. (Previously Presented) The component of claim 4, wherein the inorganic filler particle content is 15 percent or less by weight based on the weight of the polymeric composite.

6. (Previously Presented) The component of claim 4, wherein the inorganic filler particle is a smectite clay mineral.

7. (Original) The component of claim 6, wherein the smectite clay mineral is montmorillonite.

8. (Previously Presented) The component of claim 4, wherein the synthetic resin matrix is a thermoset resin.

9. (Original) The component of claim 8, wherein the thermoset resin is selected from epoxy, phenolic, polyurethane and polyurea resins.

10. (Previously Presented) The component of claim 4, wherein the synthetic resin matrix is a thermoplastic resin.

11. (Original) The component of claim 10, wherein the thermoplastic resin is selected from polyamides, copolyamides, polycarbonates, polyesters and copolymers.

12. (Previously Presented) The component of claim 4, wherein the polymeric composite has a CTE from about 5 to 20 ppm/°C.

13-23. (Cancelled)

24. (Previously Presented) An overmolded electrical component, comprising:

a substrate having an electrical circuit;

a semi-conductor chip electrically connected to the substrate, the semi-conductor chip being spaced from the substrate by a distance of from about 10 micrometers to about 150 micrometers; and

a polymeric overmolding encasing the component and formed of a polymeric composite, said polymeric overmolding filling said space defined between the semi-conductor chip and the substrate and overlying a surface of the component opposite the space;

wherein the polymer composite includes a synthetic resin matrix and inorganic filler particles substantially uniformly distributed in the synthetic resin matrix, the inorganic filler particles having a platelet structure defined by opposite substantially flat and substantially parallel faces and being characterized by a thickness between about 1 and 20 nanometers and a ratio of a surface area of a face to the thickness of at least 100, the inorganic filler particle content being 20% or less by weight based on the weight of the polymer composite.